## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | MACKIEWICZ ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,609,627	03-1997	Goicoechea et al.	128/898
*	В	US-6,503,271	01-2003	Duerig et al.	623/1.15
*	С	US-2004/0044399	03-2004	Ventura, Joseph A.	623/001.16
*	D	US-2004/0015229	01-2004	Fulkerson et al.	623/1.22
*	E	US-6,231,598	05-2001	Berry et al.	623/1.15
*	F	US-2004/0015228	01-2004	Lombardi et al.	623/1.18
*	G	US-2004/0073291	04-2004	Brown et al.	623/001.15
*	Н	US-2004/0254637	12-2004	Yang et al.	623/001.34
*	ı	US-5,741,327	04-1998	Frantzen, John J.	623/1.34
	J	US-			
	κ	US-	0		
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.